



Accredited Laboratory

A2LA has accredited

PRECISION METROLOGY, INC. - SOUTH

Dade City, FL

for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSLI Z540-1-1994 and any additional program requirements in the field of calibration. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated 8 January 2009).



Presented this 5th day of August 2015.

A handwritten signature in blue ink, written over a horizontal line.

President & CEO
For the Accreditation Council
Certificate Number 1078.02
Valid to November 30, 2017
Revised on October 2, 2017

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005
& ANSI/NCSL Z540-1-1994

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CALIBRATION

Valid To: November 30, 2017

Certificate Number: 1078.02

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations¹:

I. Dimensional

Parameter/Equipment	Range	CMC ^{2,4} (±)	Comments
Bore Gages	Up to 8 in	24 µin + 7.5 µin/in	ULM
Calipers ³	Up to 4 in (4 to 20) in (20 to 80) in	130 µin + 4.2 µin/in 170 µin + 4.2 µin/in 300 µin + 5.1 µin/in	Gage blocks
CMM ³ –			
Linear	Up to 52 in, in x, y Up to 20 in, in z	(38 + 5.2L) µin (58 + 8.1L) µin	ASME B89.4.1
Probing Analysis	---	2 µm	
Volumetric	Up to 36 in for shortest axis	(82 + 13L) µin	
Bi-Directional	---	(40 + 10L) µin	

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
Cylindrical Rings	Up to 8 in	(15 + 10D) μin	UMM and gage blocks
Cylindrical Plugs	Up to 8 in (8 to 18) in	14 μin + 6.0 μin/in 8.7 μin + 4.2 μin/in	UMM and gage blocks
Gage Amp w/ Probe ³	----	13 μin	Gage blocks
Gage Blocks	Up to 4 in (4 to 20) in	4.2 μin + 4.7 μin/in 4.6 μin + 4.7 μin/in	Gage block and comparator
Height Gages ³	Up to 48 in	(0.6R + 30L) μin	Standard reference bar
Indicators ³	Up to 4 in	(0.6R + 40L) μin	Gage blocks
Indicator Calibrators ³	----	0.6R + 19 μin	Gage amp w/probe
Length Standards	Up to 8 in (8 to 18) in	14 μin + 6.0 μin/in 8.7 μin + 4.2 μin/in	Universal measuring machine (UMM) and gage blocks
Micrometers –			
Depth ³	Up to 12 in	40 μin/in + 0.6R	Gage blocks
Inside	Up to 8 in (8 to 18) in	14 μin + 6.0 μin/in 8.7 μin + 4.2 μin/in	UMM and gage blocks
Outside ³	Up to 4 in (4 to 20) in	58 μin + 4.7 μin/in 140 μin + 4.7 μin/in	Gage blocks
Groove ³	Up to 4 in	40 μin/in + 0.6R	Gage blocks
NPT Plugs –			
Pitch Diameter Taper	Up to 2 in	(100 + 12D) μin (240 + 13D) μin/in	Thread wires, UMM

Parameter/Equipment	Range	CMC ^{2,4} (±)	Comments
Optical Comparators ³ – Squareness Linear Magnification	(0 to 360)° Up to 12 in 10x, 20x, 50x, 62.5x, 100x	2’ 0.0002 in 0.00012 in	Calibration sphere Glass scale Calibration sphere w/overlay
Protractors ³	(0 to 180)°	0.0076°	Angle blocks
Rules/Linear Scales ³	Up to 24 in	2200 μin + 11 μin/in	Digiscope master rule
Surface Plate ³ – Flatness Repeatability	24 in × 24 in to 72 in × 144 in 6 in × 6 in to 72 in x 144 in	8√ <i>D</i> μin 34 μin	Level meters (<i>D</i> is the diagonal in inches) Repeat-O-Meter
Tape Measures ³	Up to 50 ft	(0.08 + 0.003 <i>L</i>) in	Master rule
Threaded Plug Gages – Simple Pitch Diameter Major Diameter	Up to 14 in Up to 8 in (8 to 14) in	(110 + 9 <i>D</i>) μin 14 μin + 6.0 μin/in 8.7 μin + 4.2 μin/in	UMM, thread wires (Best thread wire size)
Threaded Rings – Simple Pitch Diameter Functional Diameter	Up to 14 in Up to 14 in	(140 + 9 <i>D</i>) μin (300 + 8 <i>D</i>) μin	UMM, set plug

II. Electrical – DC/Low Frequency

Parameter/Range	Frequency	CMC ^{2, 6} (±)	Comments
AC Current – Generate ³			
(29 to 330) µA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.16 % + 0.1 µA 0.12 % + 0.1 µA 0.1 % + 0.1 µA 0.24 % + 0.15 µA 0.62 % + 0.2 µA 1.3 % + 0.4 µA	Fluke 5520A
330 µA to 3.3 mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.16 % + 0.15 µA 0.1 % + 0.15 µA 0.08 % + 0.15 µA 0.16 % + 0.2 µA 0.38 % + 0.3 µA 0.8 % + 0.6 µA	
(3.3 to 33) mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.14 % + 2 µA 0.07 % + 2 µA 0.031 % + 2 µA 0.062 % + 2 µA 0.16 % + 3 µA 0.31 % + 4 µA	
(33 to 330) mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.14 % + 20 µA 0.07 % + 20 µA 0.032 % + 20 µA 0.08 % + 50 µA 0.16 % + 0.12 mA 0.31 % + 0.2 mA	
330 mA to 1.1 A	(10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.14 % + 0.1 mA 0.039 % + 0.1 mA 0.46 % + 1 mA 2.0 % + 5 mA	
(1.1 to 3) A	(10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.14 % + 0.1 mA 0.047 % + 0.1 mA 0.46 % + 1 mA 1.9 % + 5 mA	
(3 to 11) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.048 % + 5 mA 0.081 % + 2 mA 2.4 % + 2 mA	

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
AC Current – Generate ³ (cont)			
(11 to 20.5) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.095 % + 5 mA 0.12 % + 5 mA 2.4 % + 5 mA	Fluke 5520A
(20 to 150) A 150 A to 1 kA	50 Hz to 1 kHz 50 Hz to 1 kHz	0.26 % 0.51 %	Fluke 5520 w/5500A coil
AC Current – Measure ³			
Up to 100 µA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz	0.46 % + 0.03 µA 0.18 % + 0.03 µA 0.073 % + 0.03 µA 0.073 % + 0.03 µA	HP 3458A
1 mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.46 % + 0.2 µA 0.18 % + 0.2 µA 0.072 % + 0.2 µA 0.043 % + 0.2 µA 0.072 % + 0.2 µA 0.46 % + 0.4 µA 0.64 % + 1.5 µA	
10 mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.46 % + 2 µA 0.18 % + 2 µA 0.072 % + 2 µA 0.043 % + 2 µA 0.072 % + 2 µA 0.46 % + 4 µA 0.64 % + 15 µA	
100 mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.46 % + 20 µA 0.18 % + 20 µA 0.072 % + 20 µA 0.043 % + 20 µA 0.072 % + 20 µA 0.46 % + 40 µA 0.64 % + 0.25 mA	
100 mA to 1 A	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz	0.46 % + 0.2 mA 0.19 % + 0.2 mA 0.1 % + 0.2 mA 0.13 % + 0.2 mA 0.35 % + 0.2 mA 1.2 % + 0.4 mA	

Parameter/Range	Frequency	CMC ^{2,6,7} (±)	Comments
AC Current – Measure ³ (cont)			
(1 to 3) A	10 Hz to 5 kHz (5 to 10) kHz	0.18 % + 2 mA 0.41 % + 22 mA	Fluke 8845A
(3 to 10) A	10 Hz to 5 kHz (5 to 10) kHz	0.18 % + 6 mA 0.41 % + 70 mA	
AC High Voltage – Measure ³			
(1 to 2) kV _{peak}	(20 to 100) Hz (100 to 400) Hz	0.1 % + 0.12 % rng 0.46 % + 0.12 % rng	Vitrek 4620B
(2 to 20) kV _{peak}	(2 to 100) Hz	0.23 % + 0.12 % rng	
AC Power ³ – PF = 1			
(3.3 to 9) mA (9 to 33) mA (33 to 90) mA (90 to 330) mA 330 mA to 0.9 A (0.9 to 2.2) A (2.2 to 4.5) A (4.5 to 20.5) A	(10 to 65) Hz 33 mV to 1020 V	0.15 % 0.13 % 0.15 % 0.13 % 0.19 % 0.18 % 0.29 % 0.18 %	Fluke 5520A
(3.3 to 9) mA (9 to 33) mA (33 to 90) mA (90 to 330) mA 330 mA to 0.9 A (0.9 to 2.2) A (2.2 to 4.5) A (4.5 to 20.5) A	(65 to 500) Hz 33 mV to 1020 V	0.10 % 0.07 % 0.10 % 0.12 % 0.09 % 0.08 % 0.18 % 0.18 %	

Parameter/Range	Frequency	CMC ^{2, 6} (±)	Comments
AC Power ³ – (cont)			
PF = 1			
(3.3 to 9) mA	500 Hz to 1 kHz	0.10 %	Fluke 5520A
(9 to 33) mA	33 mV to 1020 V	0.07 %	
(33 to 90) mA		0.10 %	
(90 to 330) mA		0.12 %	
330 mA to 0.9 A		0.09 %	
(0.9 to 2.2) A		0.08 %	
(2.2 to 4.5) A		0.18 %	
(4.5 to 20.5) A		0.18 %	
(3.3 to 9) mA	(1 to 5) kHz	0.14 %	
(9 to 33) mA	33 mV to 1020 V	0.12 %	
(33 to 90) mA		0.21 %	
(90 to 330) mA		0.15 %	
330 mA to 0.9 A		0.69 %	
(0.9 to 2.2) A		0.56 %	
(2.2 to 4.5) A		2.5 %	
(4.5 to 20.5) A		2.5 %	
(3.3 to 9) mA	(5 to 10) kHz	0.38 %	
(9 to 33) mA	33 mV to 1020 V	0.35 %	
(33 to 90) mA		0.52 %	
(90 to 330) mA		0.38 %	
330 mA to 0.9 A		3.1 %	
(0.9 to 2.2) A		2.4 %	
(3.3 to 9) mA	(10 to 30) kHz	1.3 %	
(9 to 33) mA	33 mV to 1020 V	1.2 %	
(33 to 90) mA		1.4 %	
(90 to 330) mA		1.3 %	
AC Voltage – Generate ³			
(1 to 33) mV	(10 to 45) Hz	0.063 % + 6 μV	Fluke 5520A
	45 Hz to 10 kHz	0.017 % + 6 μV	
	(10 to 20) kHz	0.02 % + 6 μV	
	(20 to 50) kHz	0.08 % + 6 μV	
	(50 to 100) kHz	0.27 % + 12 μV	
	(100 to 500) kHz	0.62 % + 50 μV	

Parameter/Range	Frequency	CMC ^{2,5,6} (±)	Comments
AC Voltage – Generate ³ (cont)			
(33 to 330) mV	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	0.023 % + 8 μV 0.012 % + 8 μV 0.013 % + 8 μV 0.028 % + 8 μV 0.062 % + 32 μV 0.16 % + 70 μV	Fluke 5520A
330 mV to 3.3 V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	0.023 % + 50 μV 0.012 % + 60 μV 0.016 % + 60 μV 0.024 % + 50 μV 0.055 % + 0.13 mV 0.19 % + 0.6 mV	
(3.3 to 33) V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.023 % + 0.65 mV 0.012 % + 0.6 mV 0.019 % + 0.6 mV 0.028 % + 0.6 mV 0.072 % + 1.6 mV	
(33 to 330) V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.015 % + 2 mV 0.016 % + 6 mV 0.02 % + 6 mV 0.026 % + 6 mV 0.16 % + 50 mV	
(330 to 1020) V	45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.024 % + 10 mV 0.02 % + 10 mV 0.024 % + 10 mV	
AC Voltage – Measure ³			
10 mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz	0.039 % + 3 μV 0.03 % + 1.1 μV 0.039 % + 1.1 μV 0.12 % + 1.1 μV 0.58 % + 1.1 μV 4.6 % + 2 μV	HP 3458A

Parameter/Range	Frequency	CMC ^{2, 5} (±)	Comments
AC Voltage – Measure ³ (cont)			
100 mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz	0.014 % + 4 μV 0.012 % + 2 μV 0.018 % + 2 μV 0.031 % + 2 μV 0.092 % + 2 μV 0.34 % + 10 μV 1.2 % + 10 μV 1.8 % + 10 μV	HP 3458A
1 V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz	0.014 % + 40 μV 0.012 % + 20 μV 0.018 % + 20 μV 0.031 % + 20 μV 0.092 % + 20 μV 0.34 % + 0.1 mV 1.2 % + 0.1 mV 1.8 % + 0.1 mV	
10 V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz	0.014 % + 0.4 mV 0.012 % + 0.2 mV 0.018 % + 0.2 mV 0.031 % + 0.2 mV 0.092 % + 0.2 mV 0.34 % + 1 mV 1.2 % + 1 mV 1.8 % + 1 mV	
100 V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.025 % + 4 mV 0.025 % + 2 mV 0.025 % + 2 mV 0.04 % + 2 mV 0.14 % + 2 mV 0.46 % + 10 mV 1.7 % + 10 mV	
1000 V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.047 % + 40 mV 0.047 % + 20 mV 0.07 % + 20 mV 0.14 % + 20 mV 0.34 % + 20 mV	

Parameter/Equipment	Range	CMC ^{2, 5, 6, 7} (±)	Comments
Capacitance – Generate ³	(0.19 to 3.3) nF (3.3 to 11) nF (11 to 110) nF (110 to 330) nF 330 nF to 1.1 µF (1.1 to 3.3) µF (3.3 to 11) µF (11 to 33) µF (33 to 110) µF (110 to 330) µF 330 µF to 1.1 mF (1.1 to 3.3) mF (3.3 to 11) mF (11 to 33) mF	0.5 % + 0.01 nF 0.25 % + 0.01 nF 0.25 % + 0.1 nF 0.25 % + 0.3 nF 0.25 % + 1 nF 0.25 % + 3 nF 0.25 % + 10 nF 0.4 % + 30 nF 0.45 % + 100 nF 0.45 % + 300 nF 0.45 % + 1 µF 0.45 % + 3 µF 0.45 % + 10 µF 0.75 % + 30 µF	Fluke 5520A
DC Current – Generate ³	(0 to 330) µA 330 µA to 3.3 mA (3.3 to 33) mA (33 to 330) mA 330 mA to 1.1 A (1.1 to 3.0) A (3 to 11) A (11 to 20.5) A	0.012 % + 0.02 µA 79 µA/A + 0.05 µA 79 µA/A + 0.25 µA 79 µA/A + 2.5 µA 0.016 % + 40 µA 0.03 % + 40 µA 0.04 % + 500 µA 0.078 % + 750 µA	Fluke 5520A
DC Current – Measure ³	100 nA 100 nA to 1 µA (1 to 10) µA (10 to 100) µA 100 µA to 1 mA (1 to 10) mA (10 to 100) mA 100 mA to 1 A (1 to 2) A (2 to 10) A	52 mA/A + 0.04 nA 25 mA/A + 0.04 nA 25 mA/A + 0.1 nA 26 mA/A + 0.8 nA 27 mA/A + 5 nA 26 mA/A + 50 nA 42 mA/A + 0.5 mA 0.013 % + 10 mA 0.15 % 0.19 %	HP 3458A Fluke 8845A
DC High Voltage – Measure ³	(1 to 2) kV (2 to 20) kV	0.05 % + 0.023 % rng 0.46 % + 0.12 % rng	Vitrek 4620B

Parameter/Equipment	Range	CMC ^{2,5,6} (±)	Comments
DC Power ³ – 33 mV to 1020 V	330 µA to 1.1 A (1.1 to 3) A (3 to 11) A (11 to 20.5) A	0.068 % 0.070 % 0.095 % 0.12%	Fluke 5520A
DC Voltage – Generate ³	(0 to 330) µV 330 µV to 3.3 V (3.3 to 33) V (33 to 330) V (330 to 1000) V	16 µV + 1 µV 9.1 µV/V + 2 µV 11 µV/V + 20 µV 15 µV/V + 150 µV 15 µV/V + 1500 µV	Fluke 5520A
DC Voltage – Measure ³	Up to 100 mV 100 mV to 1 V (1 to 10) V (10 to 100) V (100 to 1000) V	9.6 µV/V + 0.23 µV 6.1 µV/V + 0.25 µV 5.6 µV/V + 1 µV 7.4 µV/V + 25 µV 7.6 µV/V + 100 µV	HP 3458A
Electrical Simulation of RTDs ³ –			
Pt 385, 100 Ω	-200 °C to 0 °C 0 °C to 100 °C 100 °C to 300 °C 300 °C to 400 °C 400 °C to 630 °C 630 °C to 800 °C	0.05 °C 0.07 °C 0.09 °C 0.1 °C 0.12 °C 0.23 °C	Fluke 5520A
Pt 3926, 100 Ω	-200 °C to 0 °C 0 °C to 100 °C 100 °C to 300 °C 300 °C to 400 °C 400 °C to 630 °C	0.05 °C 0.07 °C 0.09 °C 0.1 °C 0.12 °C	
PtNi 385, 120 Ω	-80 °C to 100 °C 100 °C to 260 °C	0.08 °C 0.14 °C	

Parameter/Equipment	Range	CMC ² (±)	Comments	
Electrical Simulation of RTDs ³ – (cont)				
Pt 385, 200 Ω	-200 °C to 100 °C 100 °C to 260 °C 260 °C to 300 °C 300 °C to 400 °C 400 °C to 600 °C 600 °C to 630 °C	0.04 °C 0.05 °C 0.12 °C 0.13 °C 0.14 °C 0.16 °C	Fluke 5520A	
Pt 385, 500 Ω	-200 °C to -80 °C -80 °C to 100 °C 100 °C to 260 °C 260 °C to 400 °C 400 °C to 600 °C 600 °C to 630 °C	0.04 °C 0.05 °C 0.06 °C 0.08 °C 0.09 °C 0.11 °C		
Pt 385, 1000 Ω	-200 °C to 0 °C 0 °C to 100 °C 100 °C to 260 °C 260 °C to 300 °C 300 °C to 600 °C 600 °C to 630 °C	0.03 °C 0.04 °C 0.05 °C 0.06 °C 0.07 °C 0.23 °C		
Pt 3916, 100 Ω	-200 °C to -190 °C -190 °C to -80 °C -80 °C to 0 °C 0 °C to 100 °C 100 °C to 260 °C 260 °C to 300 °C 300 °C to 400 °C 400 °C to 600 °C	0.25 °C 0.04 °C 0.05 °C 0.06 °C 0.07 °C 0.08 °C 0.09 °C 0.1 °C		
Electrical Simulation of Thermocouple ³ –				
Type E	-250 °C to -100 °C -100 °C to 650 °C 650 °C to 1000 °C	0.5 °C 0.16 °C 0.21 °C		Fluke 5520A
Type J	-210 °C to -100 °C -100 °C to 760 °C 760 °C to 1200 °C	0.28 °C 0.17 °C 0.23 °C		

Parameter/Equipment	Range	CMC ^{2,6} (±)	Comments	
Electrical Simulation of Thermocouple ³ – (cont)				
Type K	-200 °C to -100 °C -100 °C to 120 °C 120 °C to 1000 C 1000 °C to 1372 °C	0.34 °C 0.18 °C 0.26 °C 0.4 °C	Fluke 5520A	
Type S	0 °C to 250 °C 250 °C to 1400 °C 1400 °C to 1767 °C	0.47 °C 0.37 °C 0.46 °C		
Type T	-250 °C to -150 °C -150 °C to 0 °C 0 °C to 400 °C	0.63 °C 0.24 °C 0.15 °C		
Oscilloscope Calibration ³ –				
Squarewave Signal 50 Ω at 1 kHz Source	± 1 mV to 6.6 V _{p-p}	0.28 % + 40 μV		Fluke 5520A/SC1100
Squarewave Signal 1 MΩ at 1 kHz Source	± 1 mV to 130 V _{p-p}	0.12 % + 40 μV		
Leveled Sine Wave Amplitude – Range: 5 mV to 5.5 V _{p-p}	50 kHz reference 50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz	2 % + 300 μV 3.5 % + 300 μV 4 % + 300 μV 6 % + 300 μV	Fluke 5520A/SC1100, <i>t</i> is in seconds	
Range: 4 mV to 3.5 V _{p-p}	(600 to 1100) MHz	7 % + 300 μV		
Leveled Sine Wave Flatness (Relative to 50 kHz)	50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz (600 to 1100) MHz	1.5 % + 100 μV 2 % + 100 μV 4 % + 100 μV 5 % + 100 μV		
Time Marker into 50 Ω Generate and Measure	5 s to 50 ms 20 ms to 1 ns	(26 + <i>t</i> *1000) parts in 10 ⁶ 2.6 parts in 10 ⁶		
Rise Time	≤ 300 ps	+0 /-100 ps		

Parameter/Equipment	Range	CMC ^{2,5,6} (±)	Comments
Resistance – Generate ³	(0 to 11) Ω (11 to 33) Ω (33 to 110) Ω (110 to 330) Ω (330 to 1100) Ω (1.1 to 3.3) kΩ (3.3 to 11) kΩ (11 to 33) kΩ (33 to 110) kΩ (110 to 330) kΩ (330 to 1100) kΩ (1.1 to 3.3) MΩ (3.3 to 11) MΩ (11 to 33) MΩ (33 to 110) MΩ (110 to 330) MΩ (330 to 1100) MΩ	34 μΩ/Ω + 0.001 Ω 30 μΩ/Ω + 0.015 Ω 25 μΩ/Ω + 0.015 Ω 27 μΩ/Ω + 0.02 Ω 24 μΩ/Ω + 0.02 Ω 25 μΩ/Ω + 0.2 Ω 24 μΩ/Ω + 0.1 Ω 24 μΩ/Ω + 1 Ω 24 μΩ/Ω + 1 Ω 31 μΩ/Ω + 10 Ω 28 μΩ/Ω + 10 Ω 47 μΩ/Ω + 0.15 kΩ 0.011 % + 0.25 kΩ 0.02 % + 2.5 kΩ 0.039 % + 3 kΩ 0.24 % + 0.1 MΩ 1.2 % + 0.5 MΩ	Fluke 5520A
Resistance – Generate	(1 to 999) MΩ (1 to 9.9) GΩ (10 to 100) GΩ	0.13 % + 550 kΩ 0.50 % + 130 kΩ 1.0 % + 7.5 MΩ	Decade resistors
Resistance – Measure ³	(0 to 10) Ω (10 to 100) Ω 100 Ω to 1 kΩ (1 to 10) kΩ (10 to 100) kΩ 100 kΩ to 1 MΩ (1 to 10) MΩ (10 to 100) MΩ 100 MΩ to 1 GΩ	19 μΩ/Ω + 50 μΩ 14 μΩ/Ω + 0.05 mΩ 12 μΩ/Ω + 0.5 mΩ 12 μΩ/Ω + 5 mΩ 12 μΩ/Ω + 50 mΩ 17 μΩ/Ω + 2 Ω 59 μΩ/Ω + 100 Ω 0.058 % + 1 kΩ 0.58 % + 10 kΩ	HP 3458A

III. Mechanical

Parameter/Equipment	Range	CMC ^{2, 4, 7} (±)	Comments
Force Gages ³	(0 to 250) lbf	0.12 % + 0.6R	Deadweights
Indirect Verification of Rockwell Hardness and Rockwell Superficial Hardness Testers ³	<p>HRA: Low Mid High</p> <p>HRBW: Low Mid High</p> <p>HRC: Low Mid High</p> <p>HREW: Low Mid High</p> <p>HR15N: Low Mid High</p> <p>HR30N: Low Mid High</p>	<p>0.29 HRA 0.56 HRA 0.24 HRA</p> <p>0.94 HRBW 0.69 HRBW 0.62 HRBW</p> <p>0.78 HRC 0.92 HRC 0.39 HRC</p> <p>0.92 HREW 1.1 HREW 0.89 HREW</p> <p>0.76 HR15N 0.75 HR15N 1.0 HR15N</p> <p>0.55 HR30N 0.48 HR30N 0.46 HR30N</p>	ASTM E18

Parameter/Equipment	Range	CMC ^{2,7} (±)	Comments
Indirect Verification of Rockwell Hardness and Rockwell Superficial Hardness Testers ³ (cont)	HR45N: Low Mid High HR15TW: Low Mid High HR30TW: Low Mid High HR45TW: Low Mid High	0.68 HR45N 0.72 HR45N 0.66 HR45N 0.79 HR15TW 0.52 HR15TW 0.61 HR15TW 0.70 HR30TW 0.61 HR30TW 0.42 HR30TW 0.98 HR45TW 0.78 HR45TW 0.81 HR45TW	ASTM E18
Pressure Gages/Transducers ³	(0 to 2000) psig (2000 to 30 000) psig	(0.24 + 0.025 % full scale) psi (13 + 0.07 % full scale) psi	Heise HQS pressure calibrator Heise 901A pressure calibrator

Parameter/Equipment	Range	CMC ^{2,4} (±)	Comments
Scales ³	(50 to 100) lb (100 to 750) lb	0.04 lb + 0.6R 0.09 lb + 0.6R	Class F weights
Scales/Balances ³	(1 to 162) mg 162 mg to 400 g (1 to 50) lb	0.26 mg 2.6 mg 0.0028 lb	Class S1 weights
Scales ³ – Proportional Testing	(750 to 1500) lb (1500 to 3000) lb (3000 to 4500) lb (4500 to 6000) lb	0.41 lb + 0.6R 0.81 lb + 0.6R 1.3 lb + 0.6R 1.7 lb + 0.6R	Class F weights
Tachometers ³ – Photo	Up to 100 000 rpm	0.8R	Function generator
Torque Testers	(0.1 to 1000) ft·lbf	0.1 % + 0.6R	Class F weights
Torque Wrenches ³	(0 to 1000) ft·lbf (0 to 1200) in·lbf	0.62 % + 0.12 ft·lbf 0.7 % + 1.1 in·lbf	Torque calibrator

IV. Thermodynamics

Parameter/Equipment	Range	CMC ^{2,4} (±)	Comments
Temperature – Temperature Measuring Devices	@ 100 °C -30 °C to 139 °C 140 to 660 °C	0.076 °C 0.081 °C 0.25 °C	Drywell and SPRT

V. Time & Frequency

Parameter/Equipment	Range	CMC ² (±)	Comments
Frequency	0.1 Hz to 3 GHz	180 pHz/Hz + 12 pHz	GPS, frequency counter
	10 MHz	1 part in 10 ⁹ Hz/Hz	Agilent Z3801A GPS receiver
Frequency ³	0.1 Hz to 3 GHz	0.22 μHz/Hz + 1.4 μHz	Frequency counter
Stop Watches and Timers	≥ 10 ms	28 ms + 0.18 ms/s	Functional generator and frequency counter

¹ This laboratory offers commercial calibration service and field calibration service (where noted).

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ Field calibration service is available for this calibration and this laboratory meets A2LA R104 – *General Requirements: Accreditation of Field Testing and Field Calibration Laboratories* for these calibrations. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

⁴ In the statement of CMC, L is the linear displacement in inches; R is the resolution of the unit under test; D is the linear displacement in inches.

⁵ CMCs for calibrations performed in the laboratory with the HP 3458A is based upon 90-day specifications and is read as a portion or percent of reading plus a portion or percent of range. CMC for calibrations performed field with the HP 3458A is based upon 1-year specifications and is also read as a portion or percent of reading plus a portion or percent of range.

⁶ CMCs for calibrations performed with the Fluke 5520A is based upon 1-year specifications and is read as a portion or percent of reading plus a portion or percent of range or as a portion or percent of reading plus floor specification.

⁷ In the statement of CMC, percentages are to be read as percent of reading, unless noted otherwise.